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Quantum Metrology & Quantum Enhanced Measurements (with Photons)

Tuesday, 17 September 2024 14:30 (2 hours)

The objective of the lesson is to cover different aspects of quantum metrology ranging from quantum enhanced measurements to metrology for quantum technology. Some specific examples in the field of quantum photonics will be discussed.

Presenter: DEGIOVANNI, Ivo Pietro (Istituto Nazionale di Ricerca Metrologica, Italy)